

# Data Converter Fundamentals

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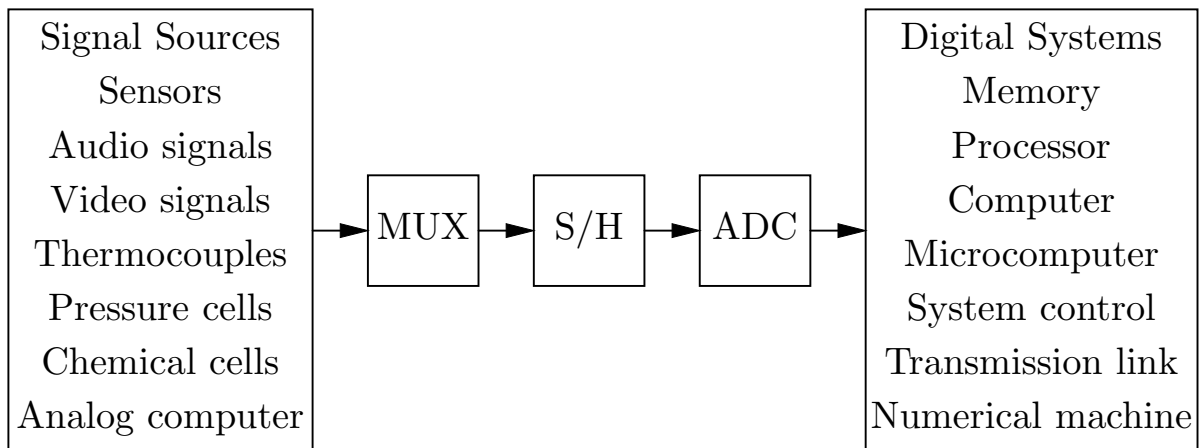
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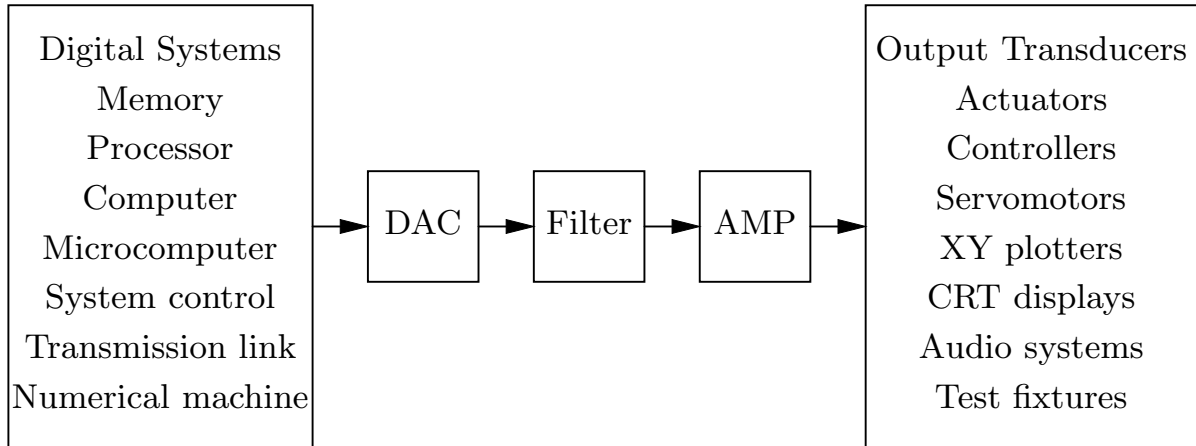
## A/D Converters in Signal Processing



Integrated Systems Lab, Kyungpook National University



## D/A Converters in Signal Processing



## Practical Applications of Data Converters

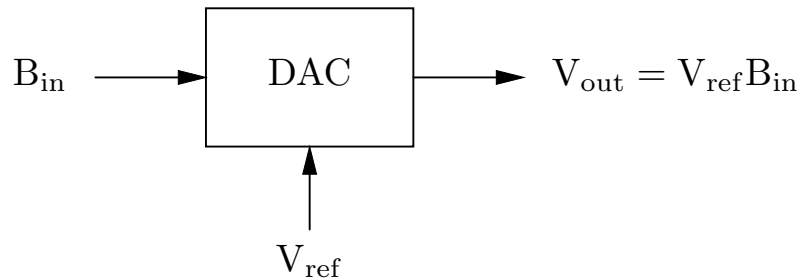
- Camcorder
- Digital camera
- CATV, HDTV
- SVGA display, PDP
- CMOS wireless transceiver design
- Hard disk read channel



## Ideal D/A Converter

□ N-bit D/A converter

digital signal  $B_{in}$ , reference voltage  $V_{ref}$ , analog output signal  $V_{out}$

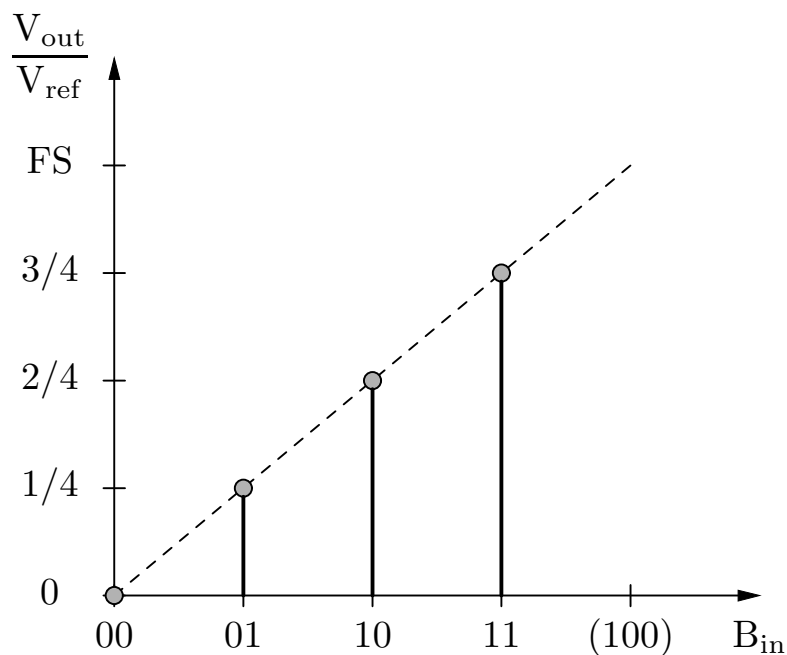


$$V_{out} = V_{ref}(b_1 2^{-1} + b_2 2^{-2} + \dots + b_N 2^{-N}) \leq V_{ref} - V_{LSB}$$

$$V_{LSB} \equiv \frac{V_{ref}}{2^N} \quad 1 \text{ LSB} \equiv \frac{1}{2^N}$$



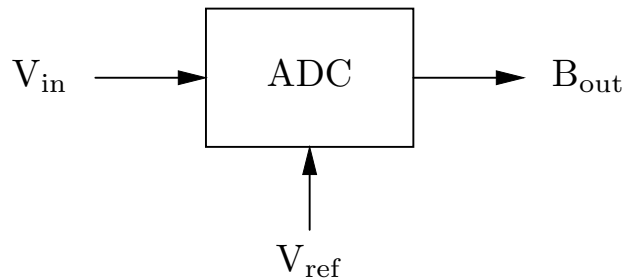
□ Transfer function for an ideal 2-bit digital-to-analog converter



## Ideal A/D Converter

□ N-bit A/D converter

analog input signal  $V_{in}$ , reference voltage  $V_{ref}$ , digital output  $B_{out}$

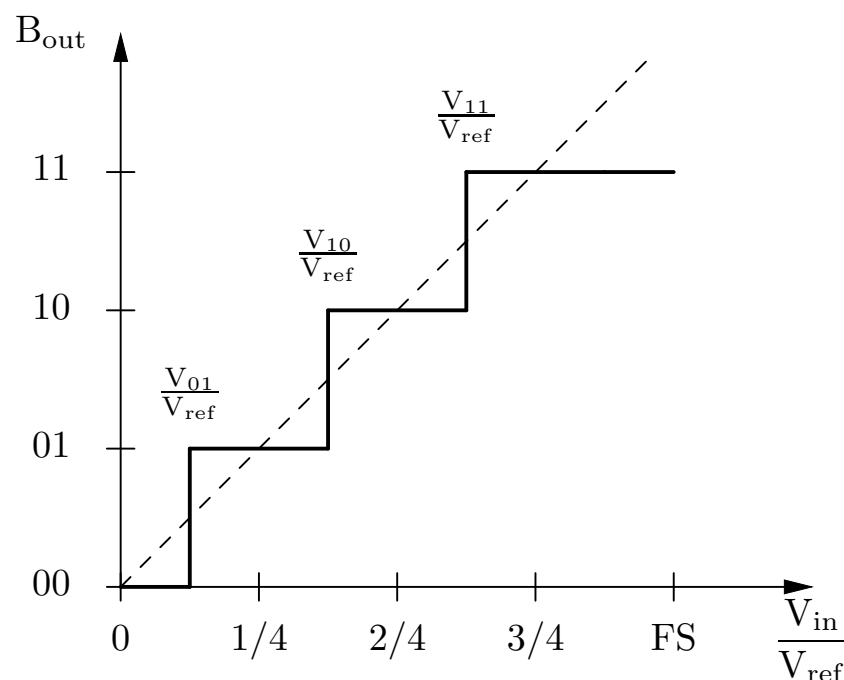


$$V_{in} + V_Q = V_{ref} B_{out} = V_{ref}(b_1 2^{-1} + b_2 2^{-2} + \dots + b_N 2^{-N})$$

$$\text{Quantization error: } -\frac{1}{2} V_{LSB} \leq V_Q < \frac{1}{2} V_{LSB}$$

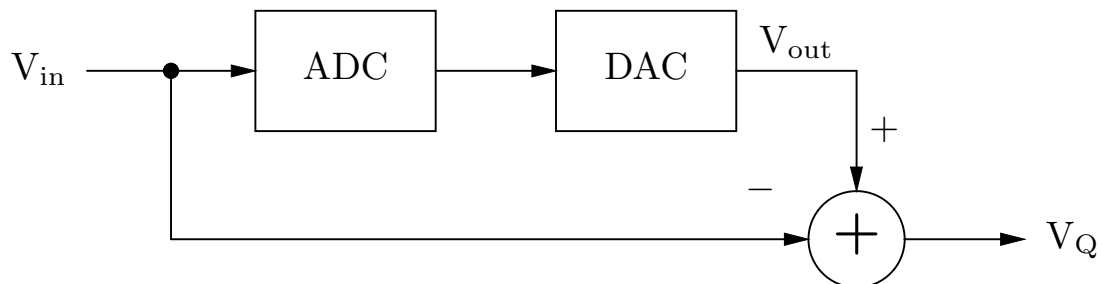


□ Transfer function for an ideal 2-bit analog-to-digital converter



## Quantization Noise of Ideal A/D Converters

□ Quantization noise: equivalent noise for quantization error



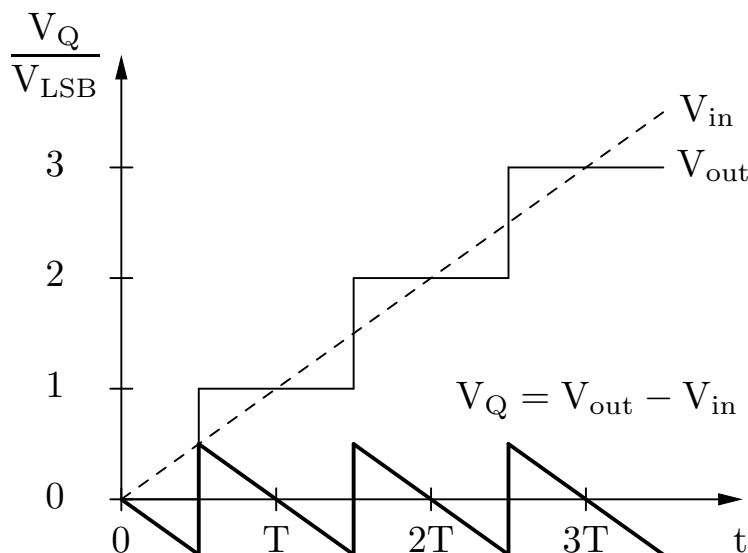
$$\text{Quantization noise} = V_Q = V_{\text{out}} - V_{\text{in}}$$

$$V_{\text{out}} = V_{\text{in}} + V_Q = \text{signal} + \text{noise}$$



□ Deterministic approach for a ramp signal

$$V_{Q(\text{rms})} = \left[ \frac{1}{T} \int_0^T V_Q^2 dt \right]^{1/2} = \left[ \frac{2}{T} \int_0^{T/2} \left( \frac{tV_{\text{LSB}}}{T} \right)^2 dt \right]^{1/2} = \frac{V_{\text{LSB}}}{\sqrt{12}}$$



- Stochastic approach for a random signal

$$\text{PDF for } V_Q = f_Q(v) = \frac{1}{V_{\text{LSB}}} \text{ for } |v| \leq \frac{V_{\text{LSB}}}{2}$$

$$\text{so that } \int_{-\infty}^{\infty} f_Q(v)dv = 1 \quad (\text{normalization})$$

$$V_{Q(\text{avg})} = \int_{-\infty}^{\infty} vf_Q(v)dv = \frac{1}{V_{\text{LSB}}} \int_{-V_{\text{LSB}}/2}^{V_{\text{LSB}}/2} vdv = 0$$

$$V_{Q(\text{rms})} = \left[ \int_{-\infty}^{\infty} v^2 f_Q(v)dv \right]^{1/2} = \left[ \frac{1}{V_{\text{LSB}}} \int_{-V_{\text{LSB}}/2}^{V_{\text{LSB}}/2} v^2 dv \right]^{1/2} = \frac{V_{\text{LSB}}}{\sqrt{12}}$$

Deterministic approach = Stochastic approach

- Noise power decreases by 6.02 dB for each additional bit



## Signal-to-Noise Ratio in A/D Converters

- Definition

$$\text{SNR} \equiv 10 \log \left( \frac{\text{signal power}}{\text{noise power}} \right) = 20 \log \left( \frac{V_{s(\text{rms})}}{V_{n(\text{rms})}} \right)$$

- $V_{\text{in}}$  = sawtooth wave bounded by  $\pm V_{\text{ref}}/2$

$$\text{SNR} = 20 \log \left( \frac{V_{\text{ref}}/\sqrt{12}}{V_{\text{LSB}}/\sqrt{12}} \right) = 20 \log(2^N) = 6.02N \text{ dB}$$

- $V_{\text{in}}$  = sinusoidal wave bounded by  $\pm V_{\text{ref}}/2$

$$\text{SNR} = 20 \log \left( \frac{V_{\text{ref}}/2\sqrt{2}}{V_{\text{LSB}}/\sqrt{12}} \right) = 20 \log \left( 2^N \sqrt{3/2} \right) = 6.02N + 1.76 \text{ dB}$$



## Signed Codes for Data Converters

### ❑ Sign magnitude

Negative number = complement of MSB for positive numbers

### ❑ 1's complement

Negative # = complement of all the bits for positive numbers

### ❑ Offset binary

Assigning 000 to the most negative number and then counting up as in the unipolar code

$$V_{\text{out of DAC}} = V_{\text{ref}}(b_1 2^{-1} + b_2 2^{-2} + \dots + b_N 2^{-N}) - 0.5V_{\text{ref}}$$

### ❑ 2's complement: subtraction is performed using addition

Negative number = 1's complement + 1

Complement of the MSB for offset-binary numbers



### ❑ 3-bit signed digital codes

Number	Sign magnitude	1's complement	Offset binary	2's complement
+3 = 011	011	011	111	011
+2 = 010	010	010	110	010
+1 = 001	001	001	101	001
+0 = 000	000	000	100	000
(-0)	(100)	(111)		
-1 = -001	101	110	011	111
-2 = -010	110	101	010	110
-3 = -011	111	100	001	101
-4 = -100		(011)	000	100



## Performances of Data Converters

□ Resolution: N-bit resolution → number of distinct analog levels

□ Offset error:  $V_{out}(0 \cdots 0) \neq 0$ ,  $V_{0 \cdots 01}$  = first transition level

$$E_{\text{off(D/A)}} = \left. \frac{V_{\text{out}}}{V_{\text{LSB}}} \right|_{0 \cdots 0} \quad E_{\text{off(A/D)}} = \frac{V_{0 \cdots 01}}{V_{\text{LSB}}} - \frac{1}{2} \text{LSB}$$

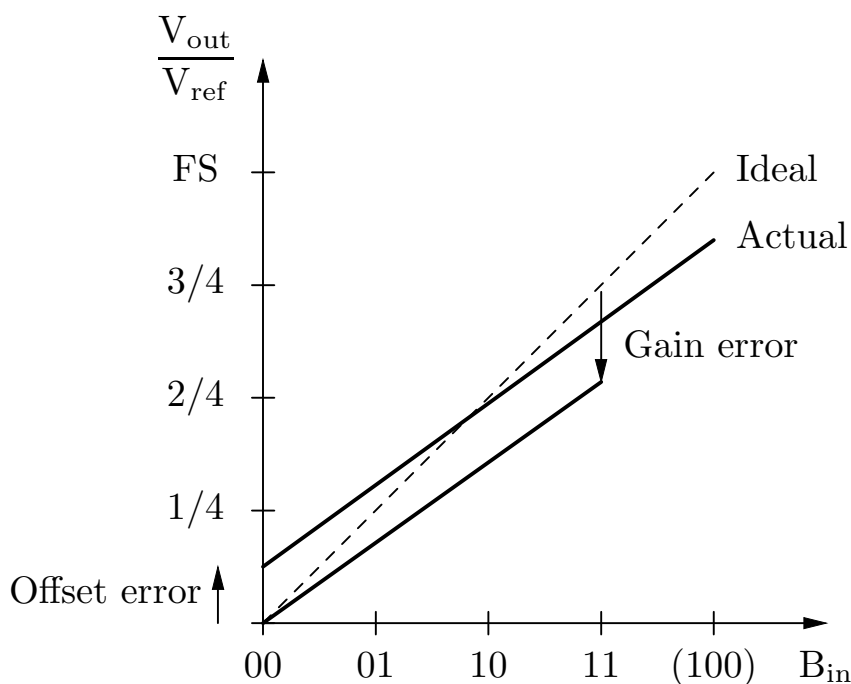
□ Gain error: when  $E_{\text{off}} \rightarrow 0$ ,  $V_{1 \cdots 1}$  = highest transition level.

$$E_{\text{gain(D/A)}} = \left. \frac{V_{\text{out}}}{V_{\text{LSB}}} \right|_{1 \cdots 1} - \left. \frac{V_{\text{out}}}{V_{\text{LSB}}} \right|_{0 \cdots 0} - (2^N - 1)$$

$$\begin{aligned} E_{\text{gain(A/D)}} &= \frac{V_{1 \cdots 1}}{V_{\text{LSB}}} - E_{\text{off(A/D)}} - \left(2^N - 1 - \frac{1}{2}\right) \\ &= \frac{V_{1 \cdots 1}}{V_{\text{LSB}}} - \frac{V_{0 \cdots 01}}{V_{\text{LSB}}} - (2^N - 2) \end{aligned}$$

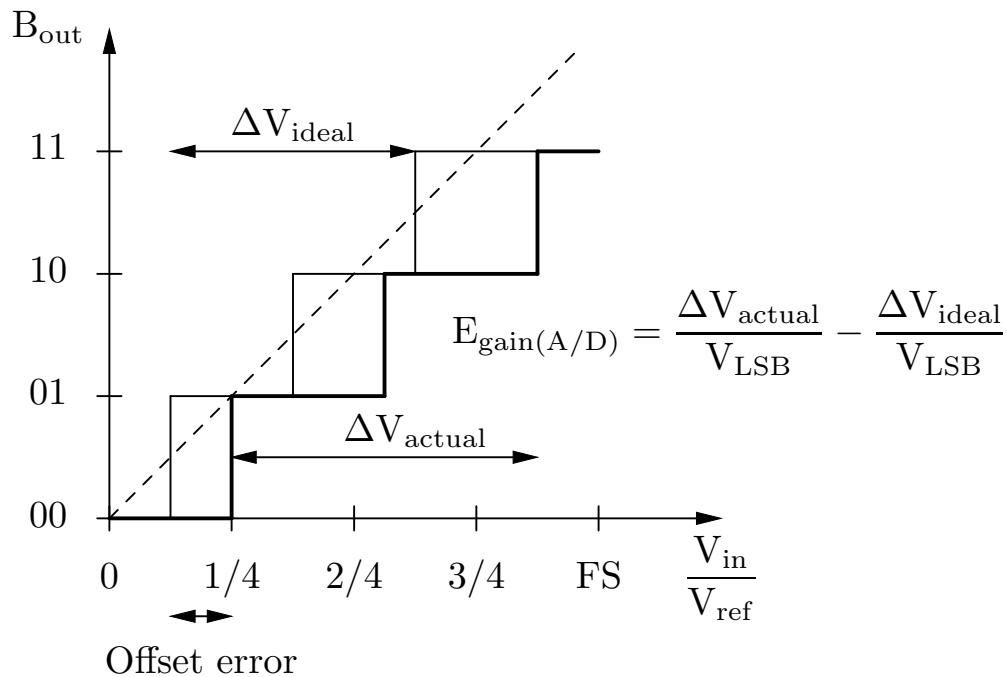


□ Illustration of offset and gain errors for a 2-bit DAC





□ Illustration of offset and gain errors for a 2-bit ADC



□ Absolute accuracy

The difference between ideal and actual transfer function  
 ⇐ offset + gain + linearity + other errors

□ Relative accuracy = maximum integral nonlinearity error

The accuracy after offset and gain errors have been removed.

□ Expression of accuracy

A % error of FS value, the effective number of bits (ENOB),  
 a fraction of an LSB

$$\text{ENOB} = \frac{\text{SNR} - 1.76}{6.02}$$

⇒ 10-bit resolution with 12-bit accuracy

⇒ 12-bit resolution with 10-bit accuracy



□ Differential nonlinearity (DNL) error

The variation in analog step sizes from ideal step size (1 LSB) after the gain and offset errors have been removed.

DNLE = maximum magnitude of the DNL values in units of LSBs

□ Integral nonlinearity (INL) error

The deviation of code midpoints from a straight line after the gain and offset errors have been removed.

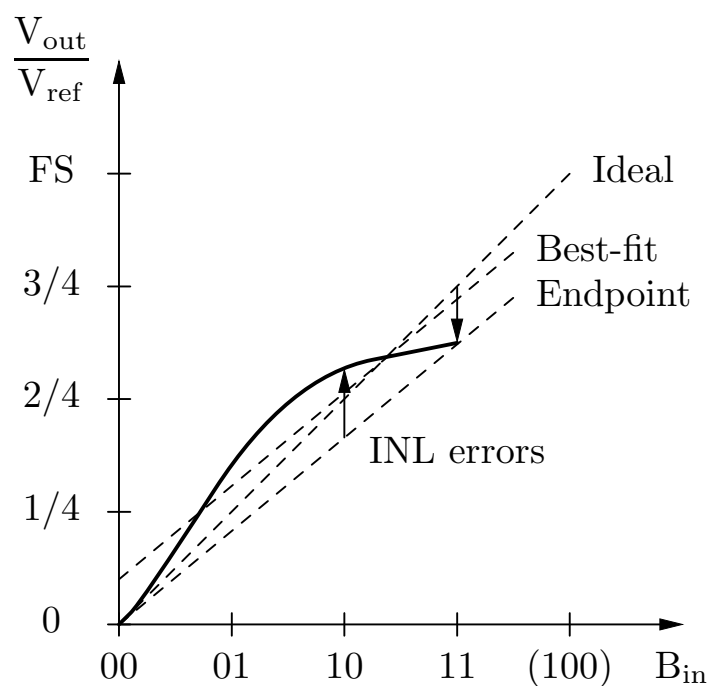
A straight line = ideal transfer function, endpoints, best-fit line

INLE = maximum magnitude of the INL values in units of LSBs

□ The INL error represents the sum (integral) of the DNL errors for inputs up to the given input.



□ Integral nonlinearity error in a 2-bit D/A converter



□ A D/A converter transfer characteristics:  $V_{\text{ref}} = 1 \text{ V}$

Digital Input	Ideal DAC Output $\times V_{\text{ref}}$	A DAC Output	Step Size (LSB)	DNLE (LSB)	INLE (LSB)
000	0.0000	0.0000			0.0
001	0.1250	0.1000	0.8	-0.2	-0.2
010	0.2500	0.2500	1.2	+0.2	0.0
011	0.3750	0.3125	0.5	-0.5	-0.5
100	0.5000	0.5625	2.0	+1.0	+0.5
101	0.6250	0.6250	0.5	-0.5	0.0
110	0.7500	0.8000	1.4	+0.4	+0.4
111	0.8750	0.8750	0.6	-0.4	0.0



□ An A/D converter transfer characteristics:  $V_{\text{ref}} = 1 \text{ V}$

Digital Output	Ideal ADC Transition Point $\times V_{\text{ref}}$	An ADC Transition Point	Step Size (LSB)	DNLE (LSB)	INLE (LSB)
000					
001	0.0625	0.0625	0.5	0.0	0.0
010	0.1875	0.2500	1.5	+0.5	+0.5
011	0.3125	0.3125	0.5	-0.5	0.0
100	0.4375	0.4375	1.0	0.0	0.0
101	0.5625	0.5625	1.0	0.0	0.0
110	0.6875	0.7500	1.5	+0.5	+0.5
111	0.8125	0.8125	0.5	-0.5	0.0



□ Monotonicity for DACs

The slope of transfer function  $> 0$

$\Leftarrow$  DNLE  $< 1$  LSB or INLE  $< 0.5$  LSB

□ Missing codes for ADCs

The ability to correspond all possible digital codes to an analog input

$\Leftarrow$  DNLE  $< 1$  LSB or INLE  $< 0.5$  LSB

□ A/D conversion time and sampling rate

The time taken to complete a single conversion including acquisition time of the input signal (multiplexing).

$$\text{Sampling rate} \leq \frac{1}{\text{Conversion time}}$$



□ D/A settling time and conversion rate

The time taken to settle to within some specified amount (usually 0.5 LSB) of the final value.

$$\text{Conversion rate} \leq \frac{1}{\text{Settling time}}$$

□ Sampling-time uncertainty = aperture jitter

For sinusoidal waveforms,

$$v = \frac{V_{\text{ref}}}{2} \sin(2\pi ft), \quad \left. \frac{\Delta v}{\Delta t} \right|_{\text{max}} = \pi f V_{\text{ref}}$$

During some sampling-time uncertainty, to keep  $\Delta v < V_{\text{LSB}}$

$$\text{Aperture jitter } \Delta t < \frac{V_{\text{LSB}}}{\pi f V_{\text{ref}}} = \frac{1}{2^N \pi f}$$



## □ Dynamic range

The ratio of the rms value of maximum amplitude input sinusoidal signal to the rms output noise plus distortion (SNDR).

The rms output noise plus distortion is obtained by eliminating the sinusoid from the measured output. For a D/A converter, the output sinusoid can be eliminated by using a spectrum analyzer. For an A/D converter, a similar approach can be taken by using FFT.

The dynamic range may be a function of the frequency of the sinusoidal input and the input signal level. The dynamic range can be expressed as an effective number of bits (ENOB).

$$\text{SNDR} = 6.02N_{\text{eff}} + 1.76$$

Example: fundamental power = 1 W, remaining power =  $0.5 \mu\text{W}$

$$\text{SNDR} = 10 \log(1/0.5\mu) = 63 \text{ dB}, N_{\text{eff}} = (63 - 1.76)/6.02 = 10.2 \text{ bits}$$

**Homework**

- Problems 11.2, 11.3, 11.7, 11.8, 11.12

